

SILICON TRANSISTOR 2SC3604

NPN EPITAXIAL SILICON TRANSISTOR FOR MICROWAVE LOW-NOISE AMPLIFICATION

The 2SC3604 is an NPN epitaxial transistor designed for low-noise amplification at 1.0 to 6.0 GHz. This transistor has low-noise and high-gain characteristics in a wide collector current region, and has a wide dynamic range.

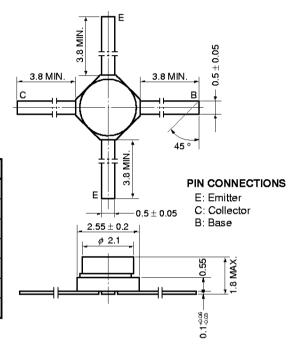
FEATURES

Low noise : NF = 1.6 dB TYP. @ f = 2.0 GHz
 High power gain : GA = 12 dB TYP. @ f = 2.0 GHz

ABSOLUTE MAXIMUM RATINGS (TA = 25 °C)

PARAMETER	SYMBOL	RATING	UNIT
Collector to Base Voltage	Vcвo	20	٧
Collector to Emitter Voltage	VCEO	10	٧
Emitter to Base Voltage	V EBO	1.5	V
Collector Current	Ic	65	mA
Total Power Dissipation	PT (TC = 25 °C)	580	mW
Junction Temperature	Tj	200	°C
Storage Temperature	Tstg	-65 to +150	°C

PACKAGE DIMENSIONS (in mm)

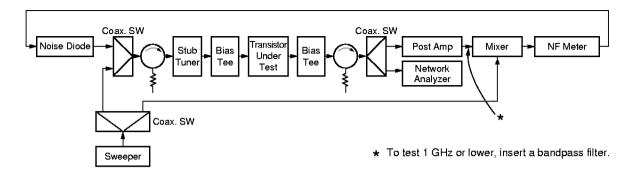


ELECTRICAL CHARACTERISTICS (TA = 25 °C)

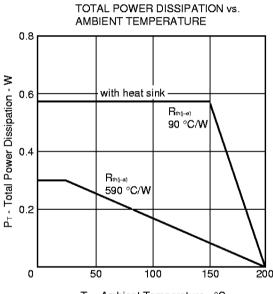
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	Ісво	VCB = 10 V, IE = 0			1.0	μΑ
Emitter Cut-off Current	Ієво	VEB = 1 V, Ic = 0			1.0	μΑ
DC Current Gain	h⊧∈	VcE = 8 V, Ic = 20 mA Pulse	50	100	250	
Gain Bandwidth Product	f⊤	VcE = 8 V, Ic = 20 mA		8		GHz
Reverse Transfer Capacitance	Cre	VCB = 10 V, IE = 0, f = 1 MHz		0.2	0.7	рF
Noise Figure	NF ^{Note}	Vce = 8 V, Ic = 7 mA, f = 2.0 GHz		1.6	2.3	dB
Insertion Gain	S 21e ²	Vce = 8 V, Ic = 20 mA, f = 2.0 GHz	9.0	11		dB
Maximum Available Gain	MAG	VcE = 8 V, Ic = 20 mA, f = 2.0 GHz		13		dB
Power Gain	GA	Vce = 8 V, Ic = 7 mA, f = 2.0 GHz		12		dB

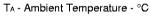


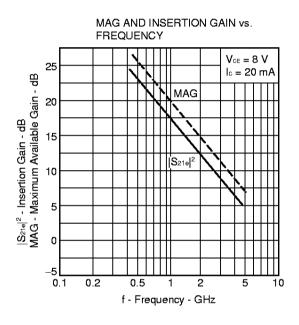
Note Test block diagram

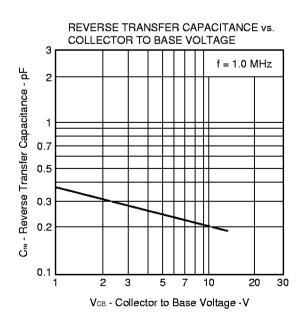


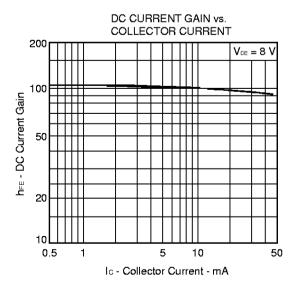
TYPICAL CHARACTERISTICS (TA = 25 °C)



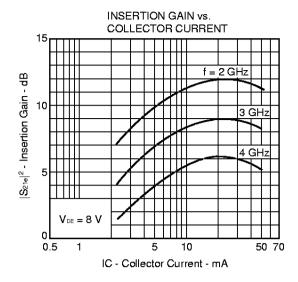


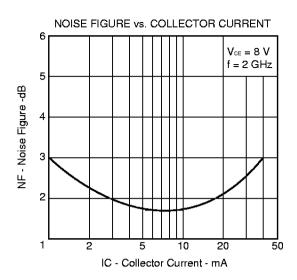


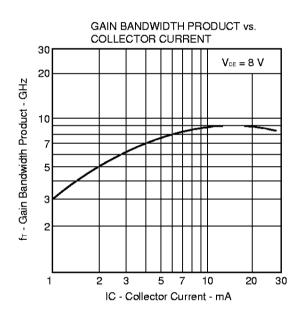












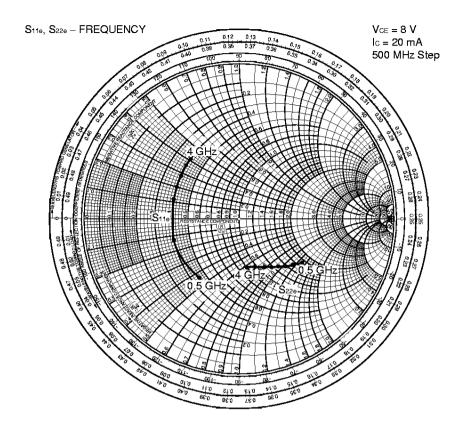
S PARAMETER

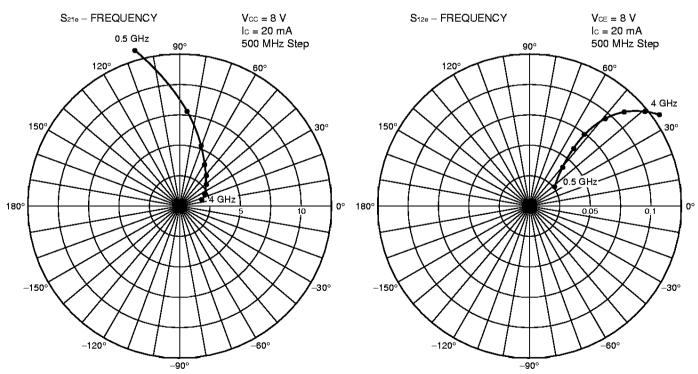
$V_{CE} = 6 V$, $I_{C} =$	= 10 mA, Zo	$= 50 \Omega$						
f (MHz)	S11	∠S11	S ₂₁	∠S ₂₁	S ₁₂	∠S ₁₂	S22	∠S22
500	.463	-125.3	13.822	106.8	.027	37.9	.516	-36.6
1000	.432	-162.7	7.901	86.2	.0424	48.2	.463	-40.7
1500	.416	178.7	5.250	71.1	.0606	53.1	.421	-46.2
2000	.439	165.0	3.949	59.7	.0758	52.0	.396	-50.9
2500	.451	153.6	3.151	51.7	.097	49.3	.372	-56.5
3000	.470	143.6	2.809	39.6	.111	45.1	.345	-63.7
3500	.482	135.2	2.337	28.6	.124	39.5	.320	-73.2
4000	.494	129.1	2.022	21.3	.132	35.5	.321	-82.0

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S PARAMETER





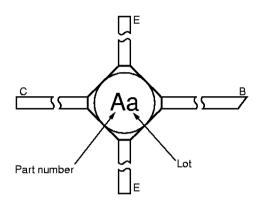


MARKING

Because the package of the micro X package transistor is too small to be marked, the following indication is employed.

Part Number

Part Number	Marking	Part Number	Marking	
2SC2148	Α	2SC3603	0	
2SC2149	В	2SC3604	2	
2SC2150	С	2SC3587	1	
2SC2367	Н			
2SC2585	K			
2SC1223	D			



Lot

Lot indication is colored as shown below.

The sequence black, brown, red, blue, and green, forms one cycle and this cycle is repeated.

Month Year	1988	1989	1990	1991	1992	1993	1994	1995	1996
1	j Black	v	h	t	f	r	d	р	b
2	k	w	i	u	g	s	е	q	С
3		х	j	v	h	t	f	r	d
4	m	у	k	w	i	u	g	s	е
5	n	Z	I	х	j	٧	h	t	f
6	0	a Brown	m	у	k	w	i	u	g
7	р	b	n	z	I	х	j	v	h
8	q	С	0	a Red	m	у	k	w	i
9	r	d	р	b	n	z	I	х	j
10	s	e	q	С	0	a Blue	m	у	k
11	t	f	r	d	р	b	n	Z	Ī
12	u	g	S	е	q	С	0	a Green	m

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[MEMO]

[MEMO]



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Standard: Computers, office equipment, communications equipment, test and measurement equipment, audio and visual equipment, home electronic appliances, machine tools, personal electronic equipment and industrial robots

Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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Anti-radioactive design is not implemented in this product.